#### MAX20086-MAX20089

### **Dual/Quad Camera Power Protectors**

### **General Description**

The MAX20086–MAX20089 dual/quad camera power protector ICs deliver up to 600mA load current to each of their four output channels. Each output is individually protected from short-to-battery, short-to-ground, and overcurrent conditions. The ICs operate from a 3V to 5.5V supply and with a 3V to 15V camera supply. The input-to-output voltage drop is only 110mV (typ) at 300mA.

The ICs provide an enable input and I<sup>2</sup>C interface to read the diagnostic status of the device. An on-board ADC enables reading of the current through each switch. The ASIL B- and ASIL D-compliant versions include support for reading an additional seven diagnostic measurements through the ADC, ensuring high-fault coverage.

The MAX20086–MAX20089 include overtemperature shutdown and overcurrent limiting on each output channel separately. All devices are designed to operate from -40°C to +125°C ambient temperature.

### **Applications**

• Power-over-Coax for Radar and Camera Modules

#### **Benefits and Features**

- Small Solution
  - Up to Four 600mA Protection Switches
  - 3V to 15V Input Supply
  - 3V to 5.5V Device Supply
  - · 26V Short-to-Battery Isolation
  - Adjustable Current Limit (100mA to 600mA)
  - Selectable I<sup>2</sup>C Addresses
  - Small (4mm x 4mm) 20-Pin SWTQFN Package
- Precision
  - ±8% Current-Limit Accuracy
  - 0.5ms Soft-Start
  - 0.25ms Soft-Shutdown
  - 0.3µA Shutdown Current
  - 110mV Drop at 300mA
- Designed for Safety Applications
  - ASIL B/D Compliant
  - Short to V<sub>BAT</sub>/GND Diagnostics
  - · Differential Output Over/Undervoltage Diagnostics
  - · Input Over/Undervoltage Diagnostics
  - Individual 8-Bit Current, Output Voltage, and Supply Readings Over I<sup>2</sup>C
  - · Autoretry on Fault
- AEC-Q100, -40°C to +125°C

Ordering Information appears at the end of data sheet.



### **Dual/Quad Camera Power Protectors**

### **Absolute Maximum Ratings**

| IN to PGNDOUT_ to IN                      | 20V to +26V                    | Continuous Power Dissipation (T <sub>A</sub> = +70 20-Pin SWTQFN-EP (derate 30.3 mW | //°C > 70°C) 2424mW |
|---|--------------------------------|---|---------------------|
| OUT_ to PGND                              | 0.3V to +26V                   | Operating Temperature   | 40°C to +125°C      |
| V <sub>DD</sub> to GND                    | 0.3V to +6V                    | Junction Temperature  | +150°C              |
| EN, ISET to GND                           | 0.3V to V <sub>DD</sub> + 0.3V | Storage Temperature Range   | 65°C to +150°C      |
| SDA, SCL, ADDR, INT to GND                | 0.3V to +6.0V                  | Lead Temperature Range  | +300°C              |
| GND to PGND                               | 0.3V to +0.3V                  |   |                     |
| Output Short-Circuit Duration, Continuous | 6                              |   |                     |
| Maximum Continuous Output Current         | 1A                             |   |                     |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# Package Information 20 SWTQFN-EP

| PACKAGE CODE  | T2044Y+4C |
|---|-----------|
| Outline Number  | 21-100068 |
| Land Pattern Number                                       | 90-0409   |
| Thermal Resistance, Single-Layer Board:                   |           |
| Junction-to-Ambient Thermal Resistance (θ <sub>JA</sub> ) | 48°C/W    |
| Junction-to-Case Thermal Resistance ( $\theta_{JC}$ )     | 2°C/W     |
| Thermal Resistance, Four-Layer Board:                     |           |
| Junction-to-Ambient Thermal Resistance (θ <sub>JA</sub> ) | 33°C/W    |
| Junction-to-Case Thermal Resistance (θ <sub>JC</sub> )    | 2°C/W     |

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

### **Electrical Characteristics**

 $(V_{DD} = 5V, V_{IN} = 6.5V, T_A = T_J = -40$ °C to +125°C, unless otherwise noted. Typical values are at  $T_A = +25$ °C under normal conditions, unless otherwise noted.) (Note 1)

| PARAMETER                                | SYMBOL              | CONDITIONS  | MIN  | TYP  | MAX  | UNITS |
|--|---------------------|---|------|------|------|-------|
| Supply Voltage Range                     | V <sub>DD</sub>     |   | 3.0  |      | 5.5  | V     |
| Shutdown Supply Current                  | I <sub>SHDN</sub>   | V <sub>EN</sub> = 0V, T <sub>A</sub> = +25°C  |      | 3    | 6.5  | μA    |
| Supply Current                           | I <sub>VDD</sub>    | V <sub>EN</sub> = 5V  |      | 2    |      | mA    |
| V <sub>DD</sub> Undervoltage Lockout     | V <sub>UVLO</sub>   | Falling   | 2.5  | 2.7  | 2.9  | V     |
| V <sub>DD</sub> Undervoltage Hysteresis  | V <sub>UVHYS</sub>  |   |      | 150  |      | mV    |
| V <sub>DD</sub> Overvoltage Lockout      | V <sub>UVLO</sub>   | Falling   | 5.5  | 5.7  | 5.9  | V     |
| V <sub>DD</sub> Overvoltage Hysteresis   | V <sub>UVHYS</sub>  |   |      | 100  |      | mV    |
| Thermal-Shutdown Temperature             | T <sub>SHDN</sub>   | T <sub>J</sub> rising   |      | 165  |      | °C    |
| Thermal-Shutdown Hysteresis              | T <sub>HYST</sub>   |   |      | 15   |      | °C    |
| SWITCH                                   |                     |   |      |      |      |       |
| Input Voltage Range                      | V <sub>IN</sub>     |   | 3.0  |      | 15   | V     |
| Input Undervoltage Lockout               | V <sub>INUVLO</sub> | Falling   | 2.5  | 2.7  | 2.9  |       |
| Input Undervoltage-Lockout<br>Hysteresis | V <sub>INUVH</sub>  |   |      | 150  |      | mV    |
| Input Overvoltage Threshold              | V <sub>INOV</sub>   | Rising  | 15.8 | 16.5 | 17.1 | V     |
| Input Overvoltage Hysteresis             |                     |   |      | 170  |      | mV    |
| Input Current                            | I <sub>IN</sub>     | V <sub>EN</sub> = 0V, T <sub>A</sub> = +25°C  |      | 0.4  |      | μΑ    |
| Input Current                            | I <sub>IN</sub>     | All switches enabled, no load   |      | 1.0  |      | mA    |
| On-Resistance                            |                     |   |      | 400  | 700  | mΩ    |
| Soft-Start Ramp Time                     | I <sub>URAMP</sub>  | 0mA to I <sub>LIM</sub>   |      | 0.5  |      | ms    |
| Soft-Shutdown Ramp Time                  | I <sub>DRAMP</sub>  | From full-on I <sub>LIM</sub> value to high impedance, any condition that turns off a channel |      | 0.25 |      | ms    |
| Overvoltage Threshold                    |                     | V <sub>OUT</sub> - V <sub>IN</sub> , rising, output disabled                                  | 0.09 | 0.15 | 0.25 | V     |
| Overvoltage Filter Time                  |                     | 1V above threshold, for short to V <sub>BAT</sub> detection                                   |      | 1    |      | μs    |
| Undervoltage Threshold                   |                     | V <sub>IN</sub> - V <sub>OUT</sub> , falling  | 0.45 | 0.55 | 0.65 | V     |
| Undervoltage Hysteresis                  |                     |   |      | 40   |      | mV    |
| Undervoltage Filter Time                 |                     | 1V below threshold  |      | 1    |      | μs    |
| CURRENT LIMIT                            |                     |   |      |      |      |       |
| ISET Operating Range                     |                     |   | 72   |      | 672  | mA    |
| OUT_ Default Current                     |                     | ISET out of operating range   |      | 600  |      | mA    |
| ISET Pullup Current                      |                     | V <sub>ISET</sub> = 1.25V   | 11.9 | 12.5 | 13.1 | μA    |
|  |                     | $R_{ISET} = 25k\Omega$  |      | 150  |      |       |
| Forward Current Limit                    | I <sub>LIM</sub>    | $R_{ISET} = 50k\Omega$ , $V_{IN} - V_{OUT} = 2V$  | -8%  | 300  | +8%  | mA    |
|  |                     | R <sub>ISET</sub> = 100kΩ   | -8%  | 600  | +8%  |       |

Electrical Characteristics (continued)  $(V_{DD} = 5V, V_{IN} = 6.5V. T_A = T_J = -40^{\circ}C$  to +125°C, unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$  under normal conditions, unless otherwise noted.) (Note 1)

| PARAMETER                                 | SYMBOL | CONDITIONS  | MIN   | TYP    | MAX   | UNITS |
|---|--------|---|-------|--------|-------|-------|
| Hard Short-Detection-Comparator Threshold |        |   | 1.8   | 1.9    | 2.0   | V     |
| Hard Short-Detection Time                 |        | Output in current limit, hard short detected                    |       | 10     |       | ms    |
| Shorted Output-Detection Time             |        | Output in current limit, UV detected                            |       | 20     |       | ms    |
| Shorted Output-Retry Time                 |        |   | 225   | 250    | 275   | ms    |
| ANALOG                                    |        |   |       |        |       |       |
| V <sub>IN</sub> Divide Ratio              |        |   | -2%   | 14.328 | +2%   | V/V   |
| V <sub>DD</sub> Divide Ratio              |        |   | -2%   | 5.1    | +2%   | V/V   |
| V <sub>ISET</sub> Divide Ratio            |        |   | -2%   | 1.02   | +2%   | V/V   |
| V <sub>OUT</sub> Divide Ratio             |        | V <sub>IN</sub> - V <sub>OUT</sub> = 200mV, excluding ADC error | -5%   | 14.328 | +5%   | V/V   |
| Output-Current Reading                    |        | I <sub>OUT</sub> = 300mA, excluding ADC error                   | -9%   | 0.616  | +9%   | A/V   |
| V <sub>IN</sub> Voltage LSB               |        |   |       | 70     |       | mV    |
| V <sub>DD</sub> Voltage LSB               |        |   |       | 25     |       | mV    |
| V <sub>ISET</sub> Voltage LSB             |        |   |       | 5      |       | mV    |
| V <sub>OUT</sub> Voltage LSB              |        |   |       | 70     |       | mV    |
| Output-Current LSB                        |        |   |       | 3      |       | mA    |
| ADC                                       |        |   |       |        |       |       |
| Resolution                                |        |   |       | 8      |       | Bits  |
| Relative Accuracy                         | INL    |   |       |        | ±1.5  | Bits  |
| Differential Accuracy                     | DNL    |   |       |        | ±1    | Bits  |
| Offset Error                              |        |   |       |        | ±2.2  | Bits  |
| Conversion Time                           |        |   |       | 1      |       | ms    |
| Track-and-Hold Acquisition Time           |        |   |       | 20     |       | μs    |
| Reference                                 |        | Full-scale reading  | 1.23% | 1.25   | 1.27% | V     |

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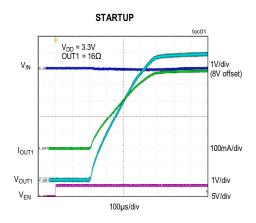
Electrical Characteristics (continued)  $(V_{DD} = 5V, V_{IN} = 6.5V. T_A = T_J = -40^{\circ}C$  to +125°C, unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$  under normal conditions, unless otherwise noted.) (Note 1)

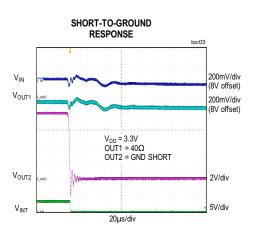
| PARAMETER                       | SYMBOL              | CONDITIONS  | MIN | TYP | MAX | UNITS |
|---------------------------------|---------------------|---|-----|-----|-----|-------|
| DIGITAL OUTPUT (INT)            |                     |   |     |     |     |       |
| Digital Output Low Level        |                     | V <sub>DD</sub> = 3.0V, I <sub>SINK</sub> = -2mA          |     |     | 0.2 | V     |
| Digital Output leakage          |                     | ERR, SDA = V <sub>DD</sub> = 5.5V                         |     |     | 1   | μA    |
| SDA OUTPUT                      |                     |   |     |     |     |       |
| SDA Output Low                  | V <sub>OL_SDA</sub> | ISINK = 13mA  |     |     | 0.4 | V     |
| DIGITAL INPUTS (EN, SDA, SCL, A | ADDR)               |   |     |     |     |       |
| Input High Level                |                     | Rising  | 1.3 |     |     | V     |
| Input Low Level                 |                     | Falling   |     |     | 0.5 | V     |
| Hysteresis                      |                     |   |     | 0.1 |     | V     |
| EN Pulldown Current             |                     | V <sub>EN</sub> = 5.0V                                    |     | 1   |     | μA    |
| ADDR Pulldown Current           |                     | V <sub>ADDR</sub> = 5.0V                                  |     | 3   |     | μA    |
| Digital Input leakage           |                     | 0 or 5.5V, V <sub>DD</sub> = 5.5V, T <sub>A</sub> = +25°C |     |     | 1   | μA    |
| I <sup>2</sup> C INTERFACE      |                     |   |     |     |     |       |
| Clock Frequency                 | f <sub>SCL</sub>    |   |     |     | 1.1 | MHz   |
| Setup Time (Repeated) START     | t <sub>SU:STA</sub> |   | 260 |     |     | ns    |
| Hold Time (Repeated) START      | t <sub>HD:STA</sub> |   | 260 |     |     | ns    |
| SCL Low Time                    | t <sub>LOW</sub>    |   | 350 |     |     | ns    |
| SCL High Time                   | tHIGH               |   | 260 |     |     | ns    |
| Data Setup Time                 | t <sub>SU:DAT</sub> |   | 50  |     |     | ns    |
| Data Hold Time                  | t <sub>HD:DAT</sub> |   | 0   |     |     | ns    |
| Setup Time for STOP Condition   | t <sub>SU:STO</sub> |   | 260 |     |     | ns    |
| Spike Suppression               |                     |   |     | 50  |     | ns    |

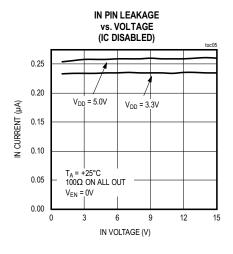
Note 1: All units are 100% production tested at +25°C. All temperature limits are guaranteed by design.

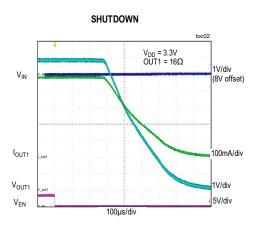
### **Typical Operating Characteristics**

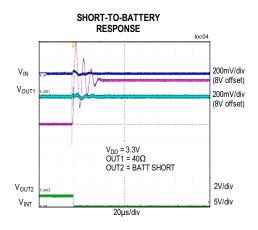
(TA = +25°C, unless otherwise noted.)

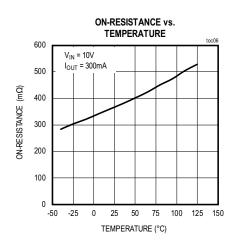




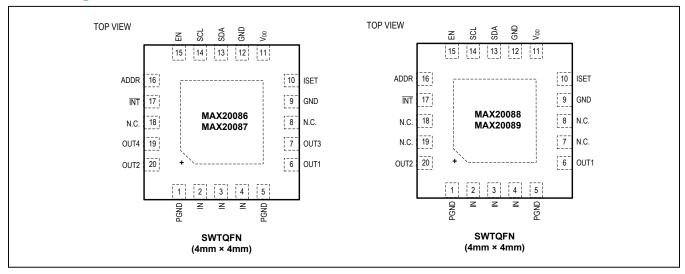








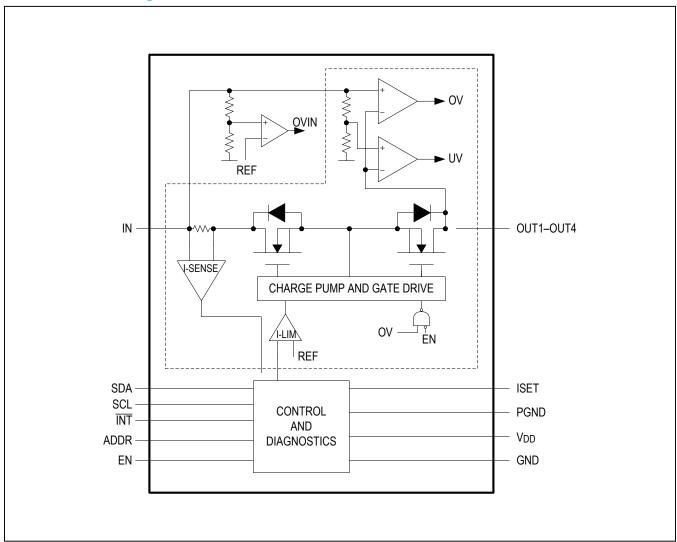
## **Pin Configurations**



### **Pin Description**

| MAX20086<br>MAX20087 | MAX20088<br>MAX20089 | NAME     | FUNCTION  |
|----------------------|----------------------|----------|---|
| 1, 5                 | 1, 5                 | PGND     | Power Ground. Connect GND and PGND together to the exposed pad (EP).  |
| 2–4                  | 2–4                  | IN       | Camera Supply. Connect to the output of the DC-DC converter feeding the cameras.  |
| 6                    | 6                    | OUT1     | Protected Camera Supply Output 1. Connect a 1μF or larger ceramic capacitor from OUT1 to PGND.  |
| 7                    | _                    | OUT3     | Protected Camera Supply Output 3. Connect a 1μF or larger ceramic capacitor from OUT3 to PGND.  |
| 8, 18                | 7, 8, 18, 19         | N.C.     | Not Connected. Leave unconnected or connect to ground.  |
| 9, 12                | 9, 12                | GND      | Analog Ground   |
| 10                   | 10                   | ISET     | Output Current-Limit Setting. Connect a resistor from ISET to GND to set the per-channel current limit.   |
| 11                   | 11                   | $V_{DD}$ | Device Input Supply. Connect a 100nF or larger ceramic capacitor from V <sub>DD</sub> to GND.   |
| 13                   | 13                   | SDA      | I <sup>2</sup> C Data I/O   |
| 14                   | 14                   | SCL      | I <sup>2</sup> C Clock Input  |
| 15                   | 15                   | EN       | Active-High Enable Input. Drive EN high for normal operation. On the rising edge, the device enters soft-start and on the falling edge, the device turns off. |
| 16                   | 16                   | ADDR     | I <sup>2</sup> C Address Select. Connect to ground or V <sub>DD</sub> to select between two different I <sup>2</sup> C addresses.                             |
| 17                   | 17                   | ĪNT      | Active-Low, Open-Drain Interrupt Output. External pullup resistor required, if used. See Table 3 and Table 11 for full behavior.                              |
| 19                   | _                    | OUT4     | Protected Camera Supply Output 4. Connect a 1μF or larger ceramic capacitor from OUT4 to PGND.  |
| 20                   | 20                   | OUT2     | Protected Camera Supply Output 2. Connect a 1μF or larger ceramic capacitor from OUT2 to PGND.  |
| _                    | _                    | EP       | Exposed Pad. Connect EP to multiple ground planes with a grid of vias for effective thermal dissipation.  |

## **Internal Block Diagram**



### **Detailed Description**

The MAX20086–MAX20089 ICs are 2-/4-channel high-side isolation/protection switches with internal current limiting and diagnostics. The input supply range is from 3V to 15V, while the output can tolerate up to 26V. Each output has an accurate current limit of  $\pm 8\%$  to protect the input supply from overload and short-circuit conditions. In a short-to-battery on the output, the switch opens to prevent back feeding of the battery to the input supply. The internal 8-bit ADC enables reading of the current from each output digitally, simplifying system design. The ICs can be configured and the status read for each channel through the I²C interface. Individual channels can also be turned on/off through I²C.

The ICs are ASIL B compliant, without additional software diagnostics. The internal 8-bit ADC is capable of reading the current and output voltage across each output, along with the voltages of the input supplies and current setting. This can increase the diagnostic coverage to achieve ASIL D compliance.

The ICs include overtemperature shutdown and overcurrent limiting separately on each channel. All devices are designed to operate from -40°C to +125°C ambient temperature.

#### I<sup>2</sup>C Interface

The ICs feature an I<sup>2</sup>C, 2-wire serial interface consisting of a serial-data line (SDA) and a serial-clock line (SCL). SDA and SCL facilitate communication between the ICs

and the master at clock rates up to 1MHz. The master, typically a microcontroller, generates SCL and initiates data transfer on the bus. Figure 1 shows the 2-wire interface timing diagram.

A master device communicates to the ICs by transmitting the proper address followed by the data word. Each transmit sequence is framed by a START (S) or Repeated START (Sr) condition, and a STOP (P) condition. Each word transmitted over the bus is 8 bits long and is always followed by an acknowledge clock pulse.

The IC's SDA line operates as both an input and an open-drain output. A pullup resistor greater than  $500\Omega$  is required on the SDA bus. The ICs' SCL line operates as an input only. A pullup resistor greater than  $500\Omega$  is required on SCL if there are multiple masters on the bus, or if the master in a single-master system has an open-drain SCL output. Series resistors in line with SDA and SCL are optional. The SCL and SDA inputs suppress noise spikes to ensure proper device operation, even on a noisy bus.

#### **Bit Transfer**

One data bit is transferred during each SCL cycle. The data on SDA must remain stable during the high period of the SCL pulse. Changes in SDA while SCL is high are control signals (see the <u>STOP and START Conditions</u> section). SDA and SCL idle high when the I<sup>2</sup>C bus is not busy.

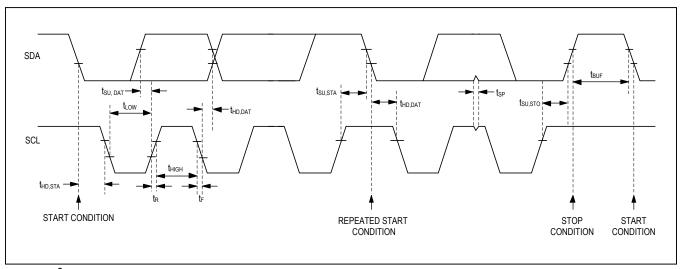


Figure 1. I<sup>2</sup>C Timing Diagram

#### **STOP and START Conditions**

A master device initiates communication by issuing a START condition. A START condition is a high-to-low transition on SDA with SCL high. A STOP condition is a low-to-high transition on SDA while SCL is high (see Figure 2). A START (S) condition from the master signals the beginning of a transmission to the IC. The master terminates transmission, and frees the bus, by issuing a STOP (P) condition. The bus remains active if a Repeated START (Sr) condition is generated instead of a STOP condition.

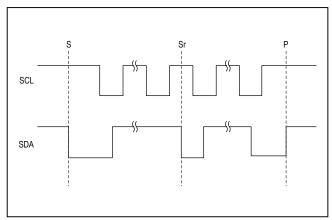


Figure 2. START, STOP, and Repeated START Conditions

### **Early STOP Condition**

The device recognizes a STOP condition at any point during data transmission, except if the STOP condition occurs in the same high pulse as a START condition.

#### **Clock Stretching**

In general, the clock-signal generation for the I<sup>2</sup>C bus is the responsibility of the master device. The I<sup>2</sup>C specification allows slow slave devices to alter the clock signal by holding down the clock line. The process in which a slave device holds down the clock line is typically called "clock stretching." The ICs do not use any form of clock stretching to hold down the clock line.

#### I<sup>2</sup>C General Call Address

The ICs do not implement the I<sup>2</sup>C specification's "general call address." If the device sees the general call address (0b0000\_0000), it does not issue an acknowledge.

#### **Slave Address**

Once the device is enabled, the I<sup>2</sup>C slave address is set by the ADDR pin (see <u>Table 1</u>). The address is defined as the 7 most significant bits (MSBs) followed by the R/W bit. Set the R/W bit to '1' to configure the device to read mode. Set the R/W bit to '0' to configure the device to write mode. The address is the first byte of information sent to the device after the START condition.

Table 1, I<sup>2</sup>C Slave Addresses

| ADDR<br>PIN | A6 | A5 | A4 | А3 | A2* | A1* | Α0 | 7-BIT<br>ADDRESS | WRITE | READ |
|-------------|----|----|----|----|-----|-----|----|------------------|-------|------|
| 0           | 0  | 1  | 0  | 1  | 0   | 0   | 0  | 0x28             | 0x50  | 0x51 |
| 1           | 0  | 1  | 0  | 1  | 0   | 0   | 1  | 0x29             | 0x52  | 0x53 |
| 0           | 0  | 1  | 0  | 1  | 0   | 1   | 0  | 0x2A             | 0x54  | 0x55 |
| 1           | 0  | 1  | 0  | 1  | 0   | 1   | 1  | 0x2B             | 0x56  | 0x57 |
| 0           | 0  | 1  | 0  | 1  | 1   | 0   | 0  | 0x2C             | 0x58  | 0x59 |
| 1           | 0  | 1  | 0  | 1  | 1   | 0   | 1  | 0x2D             | 0x5A  | 0x5B |
| 0           | 0  | 1  | 0  | 1  | 1   | 1   | 0  | 0x2E             | 0x5C  | 0x5D |
| 1           | 0  | 1  | 0  | 1  | 1   | 1   | 1  | 0x2F             | 0x5E  | 0x5F |

<sup>\*</sup>A2 and A1 can be customized at the factory.

#### **Acknowledge**

The acknowledge bit (ACK) is a clocked 9th bit that the device uses to handshake receipt each byte of data (see Figure 3). The device pulls down SDA during the mastergenerated 9th clock pulse. The SDA line must remain stable and low during the high period of the acknowledge clock pulse. Monitoring ACK allows for detection of unsuccessful data transfers. An unsuccessful data transfer occurs if a receiving device is busy, or if a system fault has occurred. In the event of an unsuccessful data transfer, the bus master can reattempt communication.

#### Write Data Format

A write to the device includes transmission of a START condition, the slave address with the write bit set to '0', 1 byte of data to the register address, 1 byte of data to the command register, and a STOP condition. Figure 4 illustrates the proper format for one frame.

#### **Read Data Format**

A read from the device includes transmission of a START condition, the slave address with the write bit set to '0', 1 byte of data to the register address, restart condition, the slave address with the read bit set to '1', 1 byte of data to the command register, and a STOP condition. Figure 4 illustrates the proper format for one frame.

#### **Enable Control Input (EN)**

The EN input activates the device from the low-power shutdown state. When the EN input goes high, channels with CONFIG.EN[4:1] bits set are enabled.

#### Interrupt Output (INT)

The ICs feature an open-drain fault-interrupt output that asserts when any unmasked fault is present.  $\overline{\text{INT}}$  remains asserted until the status registers are read. Connect a pullup resistor from  $\overline{\text{INT}}$  to the system I/O supply. The pullup resistance should normally be  $\geq 2k\Omega$  to ensure that device can pull down to the specified voltage level.

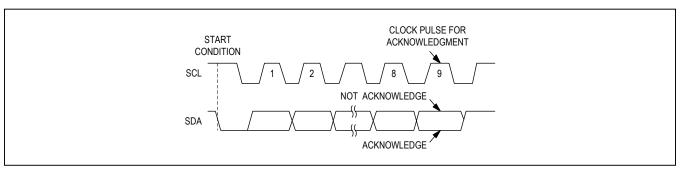


Figure 3. Acknowledge Condition

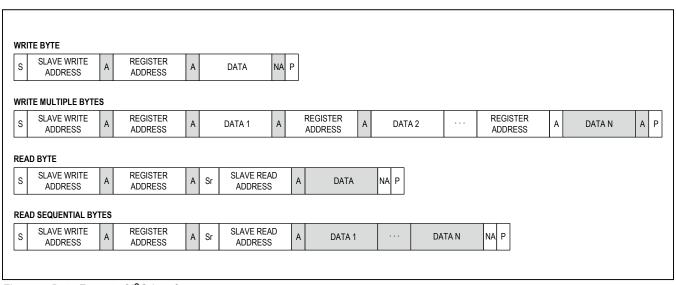


Figure 4. Data Format of I<sup>2</sup>C Interface

**Table 2. Register Map** 

| REGISTER | BIT 7 | BIT 6              | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 | CMD  | R/W  | POWER-ON<br>RESET |
|----------|-------|--------------------|-------|-------|-------|-------|-------|-------|------|------|-------------------|
| MASK     | OVTST | ACCM               | TSM   | VDDM  | VINM  | ОСМ   | OVM   | UVM   | 0x00 | R/W  | 0x00              |
| CONFIG   | MUX1  | MUX0               | ENC   | CLR   | EN4   | EN3   | EN2   | EN1   | 0x01 | R/W  | 0x1F              |
| ID       | _     | _                  | ID[   | 5:4]  |       | R[    | 3:0]  |       | 0x02 | R    | 0x00              |
| STAT1    | _     | _                  | ISET  | ACC   | OVIN  | UVIN  | OVDD  | UVDD  | 0x03 | R    | 0x00              |
| STAT2    | TS2   | OC2                | OV2   | UV2   | TS1   | OC1   | OV1   | UV1   | 0x04 | R    | 0x00              |
| SIAIZ    | TS4   | OC4                | OV4   | UV4   | TS3   | OC3   | OV3   | UV3   | 0x05 | R    | 0x00              |
| ADC1     |       |                    |       | D[7   | 7:0]  |       |       |       | 0x06 | R    | 0x00              |
| ADC2     |       | D[7:0] 0x07 R 0x00 |       |       |       |       |       | 0x00  |      |      |                   |
| ADC3     |       | D[7:0] 0x08 R 0x00 |       |       |       |       |       | 0x00  |      |      |                   |
| ADC4     |       | D[7:0]             |       |       |       |       |       | 0x09  | R    | 0x00 |                   |

### **Table 3. Interrupt Mask Register (MASK)**

|         |       |       |       | MASK  |       |       |       |       |
|---------|-------|-------|-------|-------|-------|-------|-------|-------|
| BIT NO. | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME    | OVTST | ACCM  | TSM   | VDDM  | VINM  | ОСМ   | OVM   | UVM   |
| POR     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

| BIT   | BIT DESCRIPTION  |
|-------|--|
| OVTST | Overvoltage Diagnostics Enable: The EN pin must be low to run the diagnostics. The OVIN and OV[4:1] bits in the status registers are set to '1' to indicate that comparators are operational.  0 = OV comparators function normally 1 = OV comparator diagnostics enable |
| ACCM  | 0 = ADC conversion complete, mapped to $\overline{\text{INT}}$ pin 1 = Mask ADC conversion complete  |
| TSM   | 0 = Thermal-shutdown faults TS[4:1] mapped to $\overline{\text{INT}}$ pin 1 = Mask thermal-shutdown fault  |
| VDDM  | 0 = OVDD and UVDD mapped to $\overline{\text{INT}}$ pin 1 = Mask OVIN fault  |
| VINM  | 0 = OVIN and UVIN mapped to INT pin 1 = Mask OVIN fault  |
| ОСМ   | 0 = Overcurrent faults OC[4:1] mapped to $\overline{\text{INT}}$ pin 1 = Mask short-to-ground fault  |
| OVM   | 0 = Overvoltage faults OV[4:1] mapped to $\overline{\text{INT}}$ pin 1 = Mask short-to-battery fault   |
| UVM   | 0 = Undervoltage faults UV[4:1] mapped to $\overline{\text{INT}}$ pin 1 = Mask UV fault  |

### **Table 4. Configuration Register (CONFIG)**

|         |       |       |       | CONFIG |       |       |       |       |
|---------|-------|-------|-------|--------|-------|-------|-------|-------|
| BIT NO. | BIT 7 | BIT 6 | BIT 5 | BIT 4  | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME    | MUX1  | MUX0  | ENC   | CLR    | EN4   | EN3   | EN2   | EN1   |
| POR     | 0     | 0     | 0     | 1      | 1     | 1     | 1     | 1     |

| BIT      | BIT DESCRIPTION  |
|----------|--|
| MUX[1:0] | ADC Mux Select:  00 = ADC1–ADC4 registers contain current reading of each output  MAX20087/MAX20089 Only:  01 = ADC1–ADC4 registers contain the output-voltage readings of each output  10 = ADC1–ADC3 registers contain V <sub>IN</sub> , V <sub>DD</sub> , and V <sub>ISET</sub> 11 = Reserved |
| ENC      | Enable Continuous ADC Reading:  0 = ADC conversion cycle started by reading ADC1 register; ADC1–ADC4 registers updated sequentially  1 = ADC continuously updates ADC1–ADC4 registers  |
| CLR      | Clear Faults on Read:  0 = Status registers latch faults until read through I <sup>2</sup> C  1 = Status registers show real-time fault information; INT pin reflects the real-time status   |
| EN[4:1]  | Individual Enable Control:  Both the EN pin and EN_ bit must be high to enable a channel.  0 = Disabled  1 = Enabled when EN pin is high   |

## Table 5. ID Register 1 (ID)

| ID      |       |       |                       |         |       |       |       |       |
|---------|-------|-------|-----------------------|---------|-------|-------|-------|-------|
| BIT NO. | BIT 7 | BIT 6 | BIT 5                 | BIT 4   | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME    | _     | _     | ID[                   | ID[5:4] |       | R[3   | 3:0]  |       |
| POR     | 0     | 0     | See description below |         | 0     | 0     | 0     | 0     |

| BIT     | BIT DESCRIPTION  |
|---------|--|
| ID[5:4] | Part ID Information:<br>00 = MAX20089<br>01 = MAX20088<br>10 = MAX20087<br>11 = MAX20086   |
| R[3:0]  | Revision Information: Silicon revision of device indicated by these 4 bits; revision sequential with 0x0 indicating pass 1 silicon |

Table 6. Status Register 1 (STAT1)

| STAT1   |       |       |       |       |       |       |       |       |
|---------|-------|-------|-------|-------|-------|-------|-------|-------|
| BIT NO. | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME    | _     | _     | ISET  | ACC   | OVIN  | UVIN  | OVDD  | UVDD  |
| POR     | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

| BIT  | BIT DESCRIPTION   |
|------|---|
| ISET | ISET Diagnostics Status: Use ADC reading to diagnose resistance value. 0 = ISET within operating range 1 = ISET pin open or shorted   |
| ACC  | ADC Conversion Complete: 0 = Bit is reset reading ADC1; the latest completed ADC readings are always available at ADC1–ADC4 registers 1 = ADC conversions are completed   |
| OVIN | 0 = V <sub>IN</sub> < OVIN threshold<br>1 = V <sub>IN</sub> > OVIN threshold  |
| UVIN | Input Undervoltage Lockout:  If IN voltage is below the UVLO level, this bit is set to indicate device is unable to turn on the output switches. $0 = V_{IN} > UVLO$ $1 = V_{IN} \le UVLO$ (switches are turned off)                                      |
| OVDD | V <sub>DD</sub> Overvoltage Lockout: 0 = V <sub>DD</sub> < OVDD threshold 1 = V <sub>DD</sub> > OVDD threshold  |
| UVDD | V <sub>DD</sub> Undervoltage Lockout:  If V <sub>DD</sub> voltage is below the UVLO level, this bit is set to indicate device is unable to turn on the output switches.  0 = V <sub>DD</sub> > UVLO  1 = V <sub>DD</sub> ≤ UVLO (switches are turned off) |

### **Table 7. ID Status Register 2 (STAT2)**

| STAT2 (UPPER BYTE) |       |       |       |       |       |       |       |       |
|--------------------|-------|-------|-------|-------|-------|-------|-------|-------|
| BIT NO.            | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME               | TS4   | OC4   | OV4   | UV4   | TS3   | OC3   | OV3   | UV3   |
| POR                | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

| STAT2 (LOWER BYTE) |       |       |       |       |       |       |       |       |
|--------------------|-------|-------|-------|-------|-------|-------|-------|-------|
| BIT NO.            | BIT 7 | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME               | TS2   | OC2   | OV2   | UV2   | TS1   | OC1   | OV1   | UV1   |
| POR                | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

| BIT     | BIT DESCRIPTION  |
|---------|--|
| TS[4:1] | Thermal Shutdown on OUT1-OUT4: Each channel has its own thermal sensor. 0 = No fault 1 = Thermal shutdown occurred on OUT1-OUT4  |
| OC[4:1] | Overcurrent on OUT1-OUT4: The OC bit is set when an undervoltage event persists for longer than the shorted output-detection time, If fault latching is not set, the OC bit still remains set for the duration of the 250ms hiccup cycle, and is cleared on restart after hiccup.  0 = No overcurrent present  1 = Overcurrent present |
| OV[4:1] | Overvoltage on OUT1-OUT4: 0 = Output voltage < OV threshold 1 = Output voltage > OV threshold  |
| UV[4:1] | Undervoltage on OUT1-OUT4: 0 = Output voltage > UV threshold 1 = Output voltage < UV threshold   |

## Table 8. ADC Reading Registers 1–4 (ADC1–ADC4)

|         | ADC1-ADC4 |       |       |       |       |       |       |       |
|---------|-----------|-------|-------|-------|-------|-------|-------|-------|
| BIT NO. | BIT 7     | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 |
| NAME    | D7        | D6    | D5    | D4    | D3    | D2    | D1    | D0    |
| POR     | 0         | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

| BIT    | BIT DESCRIPTION   |
|--------|---|
| D[7:0] | ADC Readings Registers:  00 = ADC1–ADC4 contain current readings of each output  MAX20087/MAX20089 Only:  01 = ADC1–ADC4 contain output-voltage readings of each output  10 = ADC1–ADC3 contain V <sub>IN</sub> , V <sub>DD</sub> , V <sub>ISET</sub> |

#### Soft-Start/Soft-Shutdown

The ICs include a fixed 0.5ms soft-start. Soft-start time limits startup inrush current by ramping the output current from 0ms to  $I_{LIM}$  set by the ISET pin. The ICs also include a soft-shutdown to minimize inductive ringing on the output channels. When disabled or faulted, the current ramps down from  $I_{LIM}$  to 0A in 0.25ms.

### **ADC Operation**

The 8-bit ADC can be used for diagnostics of the system. There are three different mux settings that allow switch current, switch voltage, and other system voltages to be read through the on-board ADC. See <u>Table 9</u> for ADC mux settings and Figure 5 for an ADC flow diagram.

**Table 9. ADC Mux Settings** 

| MUX SETTING | DESCRIPTION  |
|-------------|--|
| 00          | ADC1–ADC4 readings contain the output current through OUT1–OUT4, respectively. The current can be calculated as:  IOUT1–IOUT4 = ADC1–ADC4 x 3mA                                  |
| 01*         | ADC1–ADC4 readings contain the voltage at the output of the switches of OUT1–OUT4, respectively. The output voltage can be calculated as:  VOUT1–VOUT4 = ADC1–ADC4 x 70mV        |
| 10*         | ADC1-ADC4 contain the following voltage readings:  ADC1 = V <sub>IN</sub> (70mV/count)  ADC2 = V <sub>DD</sub> (25mV/count)  ADC3 = V <sub>ISET</sub> (5mV/count)  ADC4 = Unused |

<sup>\*</sup>Available on the ASIL-compliant versions only.

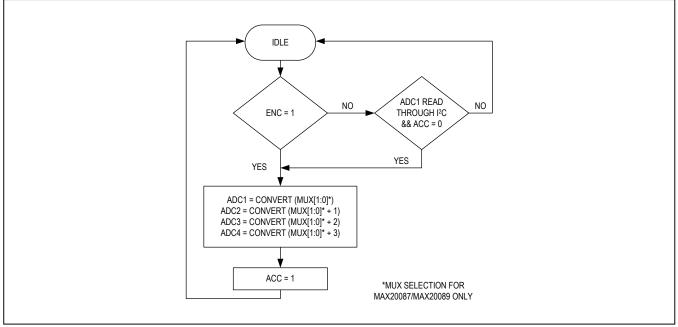


Figure 5. ADC Flow Diagram

#### **Setting the Current Limit**

Several factors determine the minimum current-limit setting for proper operation. Each output acts as a current source during the power-up phase. This means that each switch is in current limit, which is a high-power dissipation state. To protect the FETs, they can only be in current limit for a specific amount of time. It is important that the output capacitance is fully charged before this time expires. See Table 10.

The current limit can be set based on the formula in Equation 1.

#### **Equation 1:**

$$I_{LIM} = 600 \text{mA} \times \frac{R_{ISET}}{100 \text{k}\Omega}$$
 (valid between 100mA and 600mA)

#### **Current Limit/Short-Circuit Protection**

The ICs feature current limit that protects the device and remote camera module against short-circuit and overload conditions at the outputs. In the event of a short-circuit or overload condition, the current is limited to the current set by STAT1.ISET. When a channel has been in current limit for 20ms (10ms when the output voltage is < 2V), the channel turns off to prevent excessive power dissipation. If the output voltage is < 2V, the channel is re-enabled after 250ms, entering soft-start. The actual STAT2.OC[4:1] bits are latched until read by the MCU when CONFIG.CLR = '0'.

#### **Short-to-Battery Protection**

The ICs feature a differential overvoltage comparator to detect a short-to-battery condition and prevent back feeding to the input supply. The input voltage is also monitored to provide a redundant path for detection.

If a short-to-battery event occurs before an output is enabled, the output does not turn on, regardless of the

enable status. A short-to-battery condition is detected by the differential OV comparator if the part is enabled.

If the short-to-battery event occurs after an output has been enabled, the reverse-blocking FET is forced off, regardless of the enable state. The other FET remains enabled; if the short is temporary, the output remains operational, without having to go through soft-start. After the  $100\mu s$  (typ) timeout, if the OV fault is not present, the reverse-blocking FET is re-enabled.

#### **Overtemperature Protection**

Thermal-overload protection limits the total power dissipation in the device. When the junction temperature exceeds 170°C (typ) at a specific output switch, the output switch is turned off, allowing the IC to cool. All other output channels remain enabled. The thermal sensor allows the output channel to turn on again after the junction temperature cools by 15°C.

#### **OV Comparator Diagnostics**

The input and output overvoltage comparators can be tested by using the following procedure:

- 1) Set CONFIG.EN[4:1] = '0'
- 2) Set EN pin = High
- 3) IN voltage > IN UV threshold
- 4) Set MASK.OVTST = '1'
- 5) Read STAT1 and STAT2 registers and verify that the STAT1.OVIN, STAT1.OVDD, and STAT2.OV[4:1] bits are set to '1' (the STAT2.UV[4:1] bits are also set, due to disabling the outputs per step 1.)
- 6) Set MASK.OVTST = '0'

**Note:** Overvoltage and undervoltage conditions on OUT\_, IN, and  $V_{DD}$  cannot be detected while the OV comparator diagnostic is enabled.

#### **Fault Detection**

The status registers contain information on the device's status.  $\underline{\text{Table 10}}$  details the different faults and information bits within the status registers.

**Table 10. Status Registers (Faults and Information Bits)** 

| STATUS BIT | DIAGNOSTIC COVERAGE   |
|------------|---|
| ISET       | When '1' indicates the ISET pin does not have the expected resistance range connected to it. This can be a short-to-ground, open, or incorrect resistance value.  |
| UVIN       | When '1' indicates that voltage connected to the IN pin is below 2.7V. The outputs are forced off in this condition.  |
| OVIN       | When '1' indicates that voltage connected to the IN pin is above 16.5V. The outputs are forced off in this condition.   |
| UVDD       | When '1' indicates that voltage connected to the V <sub>DD</sub> pin is below 2.7V. The outputs are forced off in this condition.   |
| OVDD       | When '1' indicates that voltage connected to the V <sub>DD</sub> pin is above 5.7V. The outputs are forced off in this condition.   |
| TS[4:1]    | When any of these are '1', the associated channel(s) are in thermal shutdown. The channel remains off until the temperature drops below the thermal-shutdown hysteresis temperature.  |
| OC[4:1]    | When any of these are '1', the associated channel(s) have been in current limit and a shorted output has been detected. The channel(s) open immediately; the real-time status changes back to '0' during the hiccup phase. While the short is present, the associated OC[4:1] bit(s) toggle, but the associated UV[4:1] bit(s) remain '1', indicating the output is not in regulation.                                      |
| UV[4:1]    | When any of these are '1', the associated channel(s) output are in undervoltage. This can occur if the switch is open, either due to the EN[4:1] control bits or to a fault condition such as shorted output or thermal shutdown. The UV[4:1] bits are also '1' during the soft-start phase when the output capacitance is charging; this should not be considered a fault condition.                                       |
| OV[4:1]    | When any of these are '1', the associated channel(s) output is higher than the input voltage. This can occur if there is a short-to-battery condition, or a transient condition due to abrupt input voltage or output current changes. This fault information should be debounced in software to prevent a false fault detection. In a real fault condition, these bit(s) are '1' for the entire time the fault is present. |

### **Dual/Quad Camera Power Protectors**

### **Fault Coverage**

The MAX20087/MAX20089 ICs are ASIL B compliant at the hardware level. This means ASIL B compliance is achieved without any additional external circuits or software processing. For ASIL D compliance for safety-critical

applications, the MCU may need to use the ADC readings to increase fault coverage and verify that the MAX20087/ MAX20089 ICs and connected camera sensors are operating within their specifications. See <u>Table 11</u> for a list of faults and the associated diagnostic coverage.

**Table 11. Faults and Diagnostic Coverage** 

| FAULT  | DIAGNOSTIC COVERAGE  |
|--|--|
| Short-to-Battery on<br>OUT1–OUT4 Pins            | There are individual OV comparators on each output that can detect a shorted output to battery and turn off or prevent turning on a shorted output. In the event of a possible failure to the OV comparator, or soft-short conditions that could back feed current to the input supply, there is also an OV comparator on the input that will shut down the device to prevent system damage.           |
| Short-to-Ground or Overcurrent on OUT1–OUT4 Pins | This can be detected by the UV comparator, overcurrent condition, and the ADC reading of the current.  |
| Open on OUT1-OUT4 Pins                           | This is detected by the ADC current readings.  |
| Open on IN                                       | There are multiple pins on the input supply, so a single-point failure does not cause a failure; therefore, no diagnostic is needed. The ADC reading of the IN voltage can also detect if the IN pin is open.  |
| Incorrect Input Voltage on IN Pin                | This is detected by the ADC reading of the input voltage.  |
| Open V <sub>DD</sub> Pin                         | This is detected by loss of I <sup>2</sup> C communications.   |
| Open/Shorted ISET Pin                            | This is detected by the ADC reading of the ISET pin.   |
| Open/Shorted INT Pin                             | This fault does not cause a system malfunction, but can delay the detection of faults by the MCU. This fault can be detected by the MCU by monitoring the $\overline{\text{INT}}$ pin. The $\overline{\text{INT}}$ pin is high when the EN pin is low, and then goes low as soon as EN goes high. If there are no faults, $\overline{\text{INT}}$ goes high after all four outputs are up and running. |
| Open PGND or GND Pin                             | There are multiple pins, each to eliminate a single-point failure.   |
| Open SDA/SCL Pins                                | This is detected by loss of I <sup>2</sup> C communications.   |
| Open ADDR Pin                                    | Internal pulldown puts it into a known state. Loss of I <sup>2</sup> C for device with ADDR high is detectable through loss of communications.   |
| Open EN Pin                                      | All channels are forced off. Detectable through ADC readings of voltage drop and current.  |

### **Dual/Quad Camera Power Protectors**

### **Applications Information**

#### **Power-Over-Coaxial Cable**

One of the key applications these parts are intended for is protecting power lines that supply remote cameras/radars over coaxial cable with concurrent data transmission. As such, there are several key factors to be considered.

Combining power and communications requires filter inductors in series with the power supply to prevent them from interfering with the data communications, and coupling capacitors at the transmitter/receiver to prevent the data communications from interfering with the power

supply. The inductors must have minimal impedance at DC and low frequencies to properly provide power, but much higher impedance at the frequency bands where communication is taking place. Inversely, capacitors for the communication transmitter/receiver block DC and low-frequency signals to avoid disturbing the DC power level supplied by the converter, while passing AC data signals through across the cable. Simulation and bench testing can help determine the proper filter setup to allow for both power and data to be effectively transmitted over a coaxial cable. See Figure 6 for a system architecture diagram example.

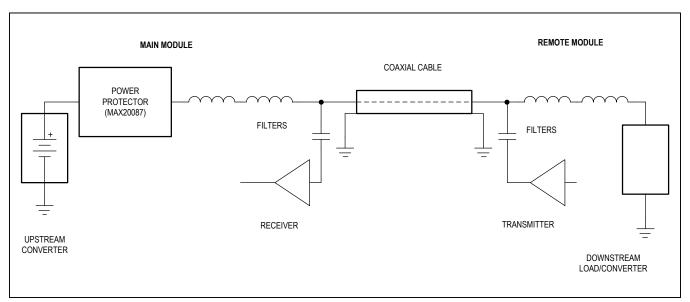
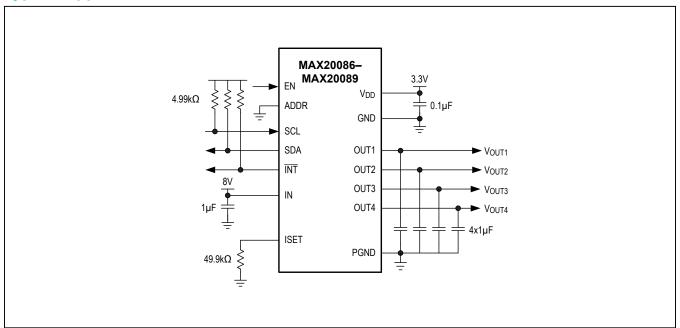


Figure 6. Example of System Architecture Diagram

### **Typical Application Circuit**



### **Ordering Information**

| PART             | TEMP RANGE      | PIN-PACKAGE   | OUTPUTS | OPTIONS      | I <sup>2</sup> C (ADDR = 0) |
|------------------|-----------------|---------------|---------|--------------|-----------------------------|
| MAX20086ATPA/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 4       | <del>_</del> | 0 X 28                      |
| MAX20087ATPA/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 4       | ASIL         | 0 X 28                      |
| MAX20087ATPB/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 4       | ASIL         | 0 X 2A                      |
| MAX20087ATPC/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 4       | ASIL         | 0 X 2C                      |
| MAX20088ATPA/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 2       | _            | 0 X 28                      |
| MAX20089ATPA/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 2       | ASIL         | 0 X 28                      |
| MAX20089ATPB/VY+ | -40°C to +125°C | 20 SWTQFN-EP* | 2       | ASIL         | 0 X 2A                      |

Note: For variants with different options, contact factory.

N Denotes an automotive-qualified part.

### **Chip Information**

PROCESS: BiCMOS

<sup>+</sup>Denotes a lead(Pb)-free/RoHS-compliant package.

SW = Side-wettable TQFN package.

<sup>\*</sup>EP = Exposed pad.

### **Revision History**

| REVISION<br>NUMBER | REVISION<br>DATE | DESCRIPTION   | PAGES<br>CHANGED |
|--------------------|------------------|---|------------------|
| 0                  | 9/17             | Initial release   | _                |
| 1                  | 9/17             | Added missing TOCs in Typical Operating Characteristics section   | 6                |
| 2                  | 1/18             | Removed future product status from MAX20086ATPA/VY, MAX20087ATPB/VY, MAX20087ATPC/VY+, MAX20088ATPA/VY+, MAX20089ATPA/VY+, and MAX20089ATPB/VY+ in Ordering Information | 21               |
| 2.1                |                  | Added future product status back to MAX20087ATPC/VY+, MAX20089ATPA/VY+, and MAX20089ATPB/VY+ in Ordering Information  | 21               |
| 3                  | 3/18             | Removed future product status from MAX20087ATPC/VY+, MAX20089ATPA/VY+, and MAX20089ATPB/VY+ in Ordering Information   | 21               |

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim Integrated's website at www.maximintegrated.com.

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